

INFORMATION DISCLOSURE STATEMENT PTO-1449			ATTY. DOCKET NO. 26822-0002 P2		SERIAL NO. 10/092,936	
			APPLICANTS: RONG, Chang-Liang, et al.			
			FILING DATE: 03/06/2002		GROUP: 2873	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
T.T.	5,177,476 *	01/05/1993	Disanto et al.	—	—	—
T.T.	5,872,552 *	02/16/1999	Gordon II et al.	—	—	—
T.T.	4,655,897 *	04/07/1987	Disanto et al.	—	—	—
T.T.	3,689,346 *	09/05/1972	Rowland	—	—	—
T.T.	5,942,154 *	08/24/1999	Kim et al.	—	—	—
T.T.	3,229,607 *	01/18/1966	Battaglia	—	—	—
T.T.	5,877,848 *	03/02/1999	Gillette et al.	—	—	—
T.T.	5,731,860 *	03/24/1998	Harada et al.	—	—	—
T.T.	5,895,541 *	04/20/1999	Kobayashi et al.	—	—	—
T.T.	5,985,084 *	11/16/1999	Summersgill et al.	—	—	—
T.T.	3,885,964 *	05/27/1975	Nacci	—	—	—
T.T.	4,741,604 *	05/03/1988	Kornfeld	—	—	—
T.T.	5,200,120 *	04/06/1993	Sakai	—	—	—
T.T.	6,113,836 *	09/05/2000	Sakai et al.	—	—	—
T.T.	6,400,492 *	06/04/2002	Morita et al.	—	—	—
T.T.	6,514,328 *	02/04/2003	Katoh et al.	—	—	—
T.T.	5,589,100 *	12/31/1996	Grasso et al.	—	—	—
T.T.	5,835,174 *	11/10/1998	Clikeman et al.	—	—	—
T.T.	5,976,405 *	11/02/1999	Clikeman et al.	—	—	—
T.T.	6,037,05 *	03/14/2000	Clikeman et al.	—	—	—
T.T.	3,908,052 *	09/23/1975	Sanders	—	—	—
T.T.	5,274,481 *	12/28/1993	Kim	—	—	—
T.T.	5,739,889 *	04/14/1998	Yamada et al.	—	—	—
T.T.	6,120,946 *	9/19/2000	Johnson et al.	—	—	—
T.T.	6,166,797 *	12/26/2000	Bruzzzone et al.	—	—	—
T.T.	5,843,333 *	12/01/1998	Hakemi	—	—	—
T.T.	5,460,688 *	10/24/1995	Disanto et al.	—	—	—
T.T.	3,892,568	07/01/1975	Ota et al.	—	—	—

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T.T.	6,191,250 *	02/20/2001	Aida et al.	—	—	—	
T.T.	4,190,352 *	02/26/1980	Bruning	—	—	—	
T.T.	4,924,257 *	05/08/1990	Jain	—	—	—	
T.T.	5,285,236 *	02/08/1994	Jain	—	—	—	
T.T.	5,652,645 *	07/29/1997	Jain	—	—	—	
T.T.	5,398,041 *	03/14/1995	Hyatt	—	—	—	
T.T.	5,432,526 *	07/11/1995	Hyatt	—	—	—	
T.T.	5,995,190 *	11/30/1999	Nagae et al.	—	—	—	
T.T.	5,956,112 *	09/21/1999	Fujimori et al.	—	—	—	
T.T.	5,450,220 *	09/12/1995	Onishi et al.	—	—	—	
T.T.	6,018,383 *	01/25/2000	Dunn et al.	—	—	—	
T.T.	2001/0009352 *	07/26/2001	Moore	—	—	—	
T.T.	2002/0029969 *	03/14/2002	Yager et al.	—	—	—	
T.T.	2002/0196525 *	12/26/2002	Chen et al.	—	—	—	
T.T.	2002/0018043 *	02/14/2002	Nakanishi	—	—	—	
T.T.	2002/0188053 *	12/12/2002	Zang et al.	—	—	—	
T.	20020126249 *	12/05/2002	Chan-Park, et al.	—	—	—	
T.	20020126249 *	09/12/2002	Liang, et al.	—	—	—	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION	
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T.T.	EP 1065553 *	Pub Date 01/03/2001	Europe (Ogawa)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
T.T.	EP 0990942 *	Pub Date 04/05/2000	Europe (Yamanaka)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
T.T.	EP 1195603 *	Pub Date 04/10/2002	Europe (Kawai)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
T.T.	JP 6242423 *	Pub Date 09/02/1994	Japan (Nakai Yuichi) (English abstract included)	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION
T.T.	JP 1-86116 *	Pub Date 01/26/1990	Japan (Seiichiro) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 60-205452 *	Pub Date 10/17/1985	Japan (Hisanori) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 2000 035677 *	Pub Date 02/02/2000	Japan (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 2000 075497 *	Pub Date 03/14/2000	Japan (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 2001 042118 *	Pub Date 02/16/2001	Japan (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 2001 056653 *	Pub Date 02/27/2001	Japan (Hayakawa) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	JP 02284126 *	Pub Date 11/21/1990	Japan (Oshiro) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
T.T.	WO 97/04398 *	Pub Date 02/06/1997	PCT (Jacobson)	—	—	<input type="checkbox"/> <input type="checkbox"/>
T.T.	WO 01/67170 *	Pub Date 09/13/2001	PCT (Liang et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
T.T.	WO 99/08151 *	Pub Date 02/18/1999	PCT (Bruzzone et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
T.T.	WO 00/03291 *	Pub Date 01/20/2000	PCT (Jacobson et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
T.T.	WO 02/01281 *	Pub Date 01/03/2002	PCT (Liang et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
T.T.	WO 99/53373 *	Pub Date 10/21/1999	PCT (Drzaic)	—	—	<input type="checkbox"/> <input type="checkbox"/>
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T.T.	* Drzaic, P.S., "Liquid Crystal Dispersions", The PDL Paradigm, pp 1-9, (1995)					
T.T.	* Singer, B. "X-Y Addressable Electrophoretic Display", Proc. SID-18 (3/4): 255-266 (1977)					
T.T.	* Kazlas, P. et al., "SVGA Microencapsulated Electrophoretic Active Matrix Display for Information Appliances" <i>SID 01 Digest</i> 152-155 (2001)					
T.T.	* Bryning et al., "Reverse-Emulsion Electrophoretic Display (REED)" <i>SID 98 Digest</i> 1018-1021 (1998)					
T.T.	* Swanson et al., "High Performance Electrophoretic Displays" <i>SID 00 Digest</i> 29-31 (2000)					
T.T.	* Inoue, S. et al., "High Resolution Microencapsulated Electrophoretic Display (EPD) Driven by Poly-Si TFTs With Four-Level Grayscale" <i>IEEE Transactions on Electron Devices</i> 49(8):1532-1539 (2002)					
T.T.	* Matsuda Y. "Newly designed, high resolution, active matrix addressing in plane EPD" <i>IDW 02 EP2-3</i> 1341-1344 (2002)					

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T.T.	* Ota et al., "Developments in Electrophoretic Displays" <i>Proc. of SID</i> 18:243-254 (1977)		
T.T.	* Kishi, E et al, "5.1 Development of In-Plane EPD", Canon Research Center, SID Digest, 2000, pp 24-27		
T.T.	USSN 09/606,654, "Manufacturing Process for Electrophoretic Display", filed 6/28/2000 (copy provided upon request)		
EXAMINER	Tuyen Tra		DATE CONSIDERED 12.02.03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*If an asterisk is placed beside the reference number, a copy is not provided because the reference was previously cited by or submitted to the PTO in a prior application that is identical in the statement and relied upon for an earlier filing date under 35 U.S.C. §120. 37 C.F.R. §1.98 (d).

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U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
	2002/0182544	12/05/02	Chan Park, et al.				
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION	
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	<i>Tungen Tsa</i>		DATE CONSIDERED <i>12-01-03</i>				

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U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
T.T.	6,512,626	01-2003	Schmidt, Fredrich Georg	359	296	—	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
T.T.	199 27 359.6	Pub. Date 12/21/00	Germany ¹	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
T.T.	WO 00/77571	Pub Date 12/21/00	PCT ¹	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
T.T.	2,340,683	Nat'l Entry Date 2/14/2001	Canada	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>Tuyen Tra</i>				DATE CONSIDERED <i>12.01.03</i>			

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¹See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.



SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION SUPPLEMENTAL PTO-1449	ATTY. DOCKET NO. 26822-0002P2	SERIAL NO. 10/092,936
	APPLICANT Rong Chang LIANG, et al.	
	FILING DATE March 6, 2002	GROUP 2873

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EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
T.T.	*6,064,508	5/2000	Forgette et al.	359	267	
T.T.	*6,239,896	5/2001	Ikeda, Tsutomu	359	240	
T.T.	*6,400,430	6/2002	Nakao et al.	349	89	
T.T.	4,891,245	1/1990	Micale	427	213.3	
T.T.	Pub No. 20020126249 (USSN 09/759,212)	09/12/02	Liang et al	349	187	
T.T.	Pub No. 20020182544 (USSN 09/784,972)	12/05/02	Chan-Park et al	430	311	

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
						<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

T.T.	Hopper et al., "An Electrophoretic Display, its Properties, Model and Addressing", IEEE Transactions on Electron Devices, 26(8):1148-1152 (1979)
T.T.	USSN 09/518,488, filed March 3, 2000 (to be provided upon request)
	USSN 09/606,654, filed June 28, 2000 (to be provided upon request)

EXAMINER: Tuyen Tra **DATE CONSIDERED:** 12.01.03

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T.T.	3,928,671	12/1975	Robusto et al.	—	—		
T.T.	6,525,865	02/2003	Katase	—	—		
	US Pub. No. 20020182544 (US 09/784,972)	12/5/2002	Chen Park, Mary et al.	—	—	02/15/2001	
	US Pub. No. 20020126249 (US 09/759,212)	0/12/2002	Liang, Rong Chang et al.	—	—	09/12/2001	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
T.T.	WO 00/36649	6/2000	PCT	—	—	<input type="checkbox"/>	<input type="checkbox"/>
T.T.	WO 98/57226	12/1998	PCT	—	—	<input type="checkbox"/>	<input type="checkbox"/>
T.T.	02284125	11/1990	Japan	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
T.T.	02223934	09/1990	Japan	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
T.T.	57104116	06/1982	Japan			<input type="checkbox"/>	<input checked="" type="checkbox"/>
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